Unit: mm

TOSHIBA Transistor Silicon NPN Epitaxial Planar Type

MT6L57AT

VHF~UHF Band Low Noise Amplifier Applications

• Two devices are built in to the super-thin and ultra super mini (6 pins) package: TU6

Mounted Devices

Licom	Q1: SSM (TESM)	Q2: SSM (TESM)
Three-pins (SSM/TESM) mold products are corresponded.	MT3S06S	MT3S04AS
	(MT3S06T)	(MT3S04AT)

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Q1	Q2	Unit	
Collector-base voltage	V_{CBO}	10	10	V	
Collector-emitter voltage	V _{CEO}	5	5	V	
Emitter-base voltage	V _{EBO}	1.5	2	V	
Collector current	I _C	15	40	mA	
Base current	Ι _Β	7	10	mA	
Collector power dissipation	PC	150		mW	
Junction temperature	Tj	125		°C	
Storage temperature range	T _{stg}	-55~125		°C	

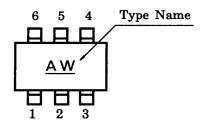
1.COLLECTOR1 4.BASE2 2.EMITTER1 5.EMITTER2 3.COLLECTOR2 6.BASE1

Weight: 0.0045 g (typ.)

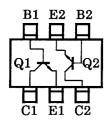
2-2JA1C

JEDEC JEITA TOSHIBA

Marking



Pin Assignment (top view)





Electrical Characteristics Q1 (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Collector cut-off current	I _{CBO}	$V_{CB} = 5 \text{ V}, I_{E} = 0$	_	_	0.1	μА	
Emitter cut-off current	I _{EBO}	V _{EB} = 1 V, I _C = 0	_	_	1	μА	
DC current gain	h _{FE}	V _{CE} = 1 V, I _C = 5 mA	70	_	140		
Transition frequency	f _T	V _{CE} = 3 V, I _C = 5 mA	7	10	_	GHz	
Insertion gain	S _{21e} ² (1)	$V_{CE} = 1 \text{ V}, I_{C} = 5 \text{ mA}, f = 2 \text{ GHz}$	_	7.5	_	dB	
	S _{21e} ² (2)	$V_{CE} = 3 \text{ V}, I_{C} = 7 \text{ mA}, f = 2 \text{ GHz}$	4.5	8	_		
Noise figure	NF (1)	$V_{CE} = 1 \text{ V}, I_{C} = 3 \text{ mA}, f = 2 \text{ GHz}$	_	1.7	3	dB	
	NF (2)	$V_{CE} = 3 \text{ V}, I_{C} = 3 \text{ mA}, f = 2 \text{ GHz}$	_	1.6	3		
Reverse transfer capacitance	C _{re}	$V_{CB} = 1 \text{ V}, I_E = 0, f = 1 \text{ MHz}$ (Note)	_	0.35	0.75	pF	

Note: Cre is measured by 3 terminal method with capacitance bridge.

Electrical Characteristics Q2 (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	V _{CB} = 5 V, I _E = 0	_	_	0.1	μΑ
Emitter cut-off current	I _{EBO}	V _{EB} = 1 V, I _C = 0	_	_	1	μΑ
DC current gain	h _{FE}	V _{CE} = 1 V, I _C = 5 mA	80	_	160	
Transition frequency	f _T (1)	$V_{CE} = 1 \text{ V}, I_{C} = 5 \text{ mA}$	2	4.5	_	GHz
	f _T (2)	$V_{CE} = 3 \text{ V}, I_{C} = 7 \text{ mA}$	5	7	_	
Insertion gain	S _{21e} ² (1)	$V_{CE} = 1 \text{ V}, I_{C} = 5 \text{ mA}, f = 1 \text{ GHz}$	_	8.5	_	dB
	S _{21e} ² (2)	$V_{CE} = 3 \text{ V}, I_{C} = 20 \text{ mA}, f = 1 \text{ GHz}$	7.5	11	_	
Noise figure	NF (1)	$V_{CE} = 1 \text{ V}, I_C = 5 \text{ mA}, f = 1 \text{ GHz}$	_	1.3	2.2	- dB
	NF (2)	$V_{CE} = 3 \text{ V}, I_{C} = 7 \text{ mA}, f = 1 \text{ GHz}$	_	1.2	2	
Reverse transfer capacitance	C _{re}	$V_{CB} = 1 \text{ V}, I_E = 0, f = 1 \text{ MHz}$ (Note)		0.9	1.25	pF

Note: Cre is measured by 3 terminal method with capacitance bridge.

Handling Precaution

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

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